## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
09944424	FUTAMURA ET AL.
Examiner	Art Unit
Revak, Christopher A	2131

SEARCHED						
Class		Subclass	Date	Examiner		
none	none		6/7/07	CR		

SEARCH NOTES					
Search Notes	Date	Examiner			
BRS Text Search: USPAT, US PGPUB, USOCR, FPRS, DERWENT, IBM TDB, EPO, JPO (see attached strategy)	6/7/07	CR			
Interference Search (see attached strategy)	6/7/07	CR			
DIALOG Text Search: COMPSCI, ELECTRON, SOFTWARE (see attached strategy)	6/7/07	CR			

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			
713	150,155,156,168,175,176,182-186	6/7/07	CR			
726	5-7,10,17,19	6/7/07	CR			
382	100,115-127	6/7/07	CR			